

FTP06N06N

N-Channel MOSFET

Applications:

- Adaptor
- Charger
- .SMPS

Features:

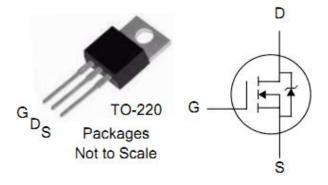
- RoHS Compliant
- Low ON Resistance
- Low Gate Charge
- Peak Current vs Pulse Width Curve
- Inductive Switching Curves

Ordering Information

PART NUMBER		PACKAGE	BRAND
	FTP06N06N	TO-220	IPS



V_{DSS}	R _{DS(ON)} (Typ.)	I _D (Silicon
60V	$4.5 m\Omega$	120A



Absolute Maximum Ratings $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	FTP06N06N	Units
V _{DSS}	Drain-to-Source Voltage	60	V
I _D	Continuous Drain Current	120	А
	Continuous Drain Current T _C =100°C	76	А
I _{DM}	Pulsed Drain Current (NOTE *1)	480	Α
V _{GS}	Gate-to-Source Voltage	±20	V
E _{AS}	Single Pulse Avalanche Energy(NOTE *2)	822	mJ
TL	Maximum Temperature for Soldering	300	
T _J and T _{STG}	Operating Junction and Storage Temperature Range	150,-55 to150	${\mathbb C}$



OFF Characteristics $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown	60			V	V_{GS} =0V, I_D =250 μ A
	Voltage				V	
				1		V_{DS} =60V, V_{GS} =0V
	Drain to Source Lookage Current	1	'		T _a =25℃	
I _{DSS}	Drain-to-Source Leakage Current			500	μA	V_{DS} =48V, V_{GS} =0V
				500		T _a =125℃
	Gate-to-Source Forward Leakage			+100	n 1	V _{GS} =+20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

ON Characteristics $T_J=25^{\circ}\mathbb{C}$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
R _{DS(ON)}	StaticDrain-to-Source On-Resistance		4.5	6	mΩ	V_{GS} =10V, I_D =40A	
V _{GS(TH)}	Gate Threshold Voltage	2	3	4	V	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	
Pulse width ≤	Pulse width ≤300µs; duty cycle≤ 2%						

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Rg	Gate Resistance		1.0		Ω	$f=1MHz$, $V_{GS}=0V$,
11.9	Cate Resistance		1.0			V _{DS} =0V
C _{iss}	Input Capacitance		3238		pF	$V_{GS} = 0V, V_{DS} = 25V$ f =1.0MHz
Coss	Output Capacitance		580			
C _{rss}	Reverse Transfer Capacitance		411			
Q_g	Total Gate Charge		76.7			$I_D = 60A, V_{DD} = 48V$ $V_{GS} = 10V$
Q _{gs}	Gate-to-Source Charge		14.1		nC	
Q_gd	Gate-to-Drain ("Miller") Charge		34.3			

Resistive Switching Characteristics Essentially independent of operating temperature

						<i>-</i>
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
t _{d(ON)}	Turn-on Delay Time		24.4		ns	V_{DD} =30V, I_{D} =60A, V_{G} =10V R_{G} =6 Ω
t _{rise}	Rise Time		20			
t _{d(OFF)}	Turn-Off Delay Time		57.8			
t _{fall}	Fall Time		26			



Source-Drain Diode Characteristics Tc=25 ℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
	Continuous Source Current			120	Α	T _C =25℃
I _S	(Body Diode)					
	Maximum Pulsed Current			480	Α	
I _{SM}	(Body Diode)			400		
V_{SD}	Diode Forward Voltage			1.2	V	I_{SD} =30A, V_{GS} =0V
t _{rr}	Reverse Recovery Time		35.9		ns	I _F =20A
Q _{rr}	Reverse Recovery Charge		40.4		nC	di/dt=100A/us
Pulse width	Pulse width ≤300µs; duty cycle ≤ 2%					

Notes:

^{*1.} Repetitive rating; pulse width limited by maximum junction temperature.

^{*2.} L=0.5mH, I_D =57.3A, Start T_J =25 $^{\circ}$ C



Test Circuits and Waveforms

Figure 14. Gate Charge Test Circuit

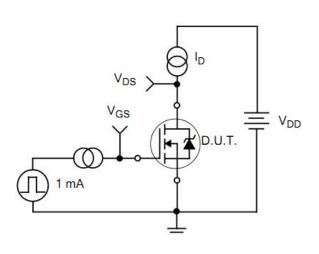


Figure 15. Gate Charge Waveforms

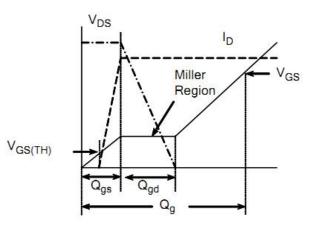
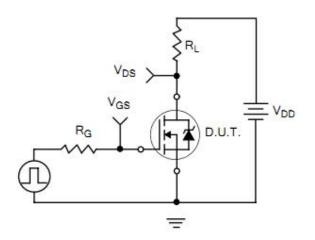


Figure 16. Resistive Switching Test Circuit

Figure 17. Resistive Switching Waveforms



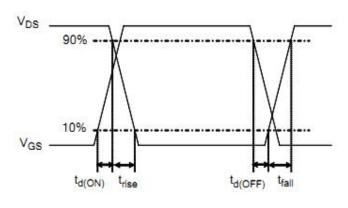




Figure 18. Diode Reverse Recovery Test Circuit

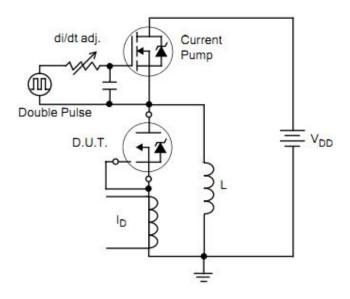


Figure 19. Diode Reverse Recovery Waveform

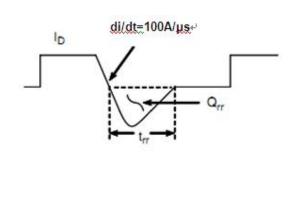
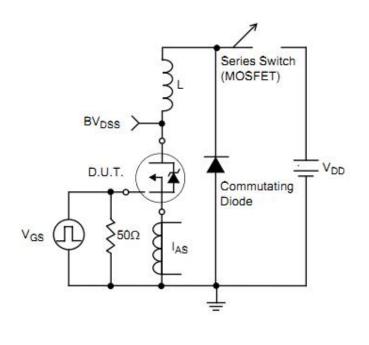
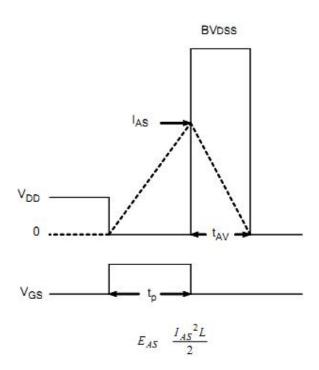


Figure 20. Unclamped Inductive Switching Test Circuit

Figure21.Unclamped Inductive Switching Waveform





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FTP06N06N Preliminary. Dec. 2017



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